Supplementary materials



Fig. S1a Rietveld refinement of the XRD pattern of the $(Ho_xTi_{1-x})_4O_{8-2x}$ (x=0.684).



Fig. S1b Rietveld refinement of the XRD pattern of the $(Ho_xTi_{1-x})_4O_{8-2x}$ (x=0.750).



Fig. S2 SEM image and X-ray mapping of $(Ho_x Ti_{1-x})_4 O_{8-2x}$ (x = 0.765) ceramic. Green – Ti. Red – Ho.



Fig. S3a Impedance spectra of the Ho_xTi_{1-x})₄O_{8-2x} (x = 0.75), equilibrated in dry air at 300 °C, and measured after changing to wet air and keeping for different times in wet atmosphere.



Fig. S3b Impedance spectra of the Ho_xTi_{1-x})₄O_{8-2x} (x = 0.75), equilibrated in dry air at 450 °C, and measured after changing to wet air and keeping for different times in wet atmosphere.



Fig. S3c Bulk (σ_b) and specific grain-boundary conductivity ($\sigma_{gb}^{sp} = (C_1/C_2) \times \sigma_{gb}^{app}$) as a function of *x*.



Fig. S4 DSC data for the first heating of the sample $(Ho_x Ti_{1-x})_4 O_{8-2x}$ (x = 0.750) without prehydration.